

Notice of References Cited	Application/Control No. 10/506,453		Applicant(s)/Patent Under Reexamination ENDO ET AL.	
	Examiner TUAN H. LE		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,304,313	10-2001	Honma, Hideo	355/18
*	B	US-6,273,535	08-2001	Inoue et al.	347/3
*	C	US-7,310,112	12-2007	Watanabe, Mikio	348/207.1
*	D	US-2002/0105678	08-2002	Shiraiwa, Yoshinobu	358/1.15
*	E	US-2001/0004266	06-2001	Itsukaichi, Masakatsu	348/220
*	F	US-6,806,978	10-2004	Tamura et al.	358/1.15
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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